

HMS32N65F
650V N-Channel Super Junction MOSFET

Features

- Very Low FOM ($R_{DS(on)} \times Q_g$)
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

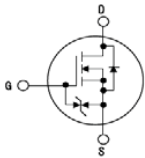
Application

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC to DC Converters
- Telecom, Solar

Key Parameters

Parameter	Value	Unit
$BV_{DSS} @T_{j,max}$	700	V
I_D	32	A
$R_{DS(on), max}$	99	mΩ
Q_g, Typ	75	nC

Package & Internal Circuit

TO-220F	SYMBOL
	

Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	650	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C = 25^{\circ}C$)	32	A
	Drain Current - Continuous ($T_C = 100^{\circ}C$)	22.4	A
$I_{DM}^{1)}$	Drain Current - Pulsed	96	A
$E_{AS}^{2)}$	Single Pulsed Avalanche Energy	546	mJ
I_{AR}	Avalanche Current	3.4	A
dv/dt	MOSFET dv/dt ruggedness, $V_{DS}=0 \dots 400V$	50	V/ns
dv/dt	Reverse diode dv/dt, $V_{DS}=0 \dots 400V, I_{DS} \leq I_D$	15	V/ns
P_D	Power Dissipation ($T_C = 25^{\circ}C$)	205	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, $R=1.5K\Omega$)	2000	V
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^{\circ}C$

Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.61	$^{\circ}C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	62.5	$^{\circ}C/W$

Electrical Characteristics $T_J=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
On Characteristics						
V _{GS}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 1.29 mA	3.0	-	4.0	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 11.9 A	-	-	99	mΩ
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1mA	650	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0	-	-	5	μA
		V _{DS} = 650 V, T _C = 150°C	-	-	100	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V	-	-	±1	μA
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 400 V, V _{GS} = 0 V, f = 1.0 MHz	-	3300	-	pF
C _{oss}	Output Capacitance		-	69	-	pF
C _{rss}	Reverse Transfer Capacitance		-	3.7	-	pF
Switching Characteristics						
t _{d(on)}	Turn-On Time	V _{DS} = 325 V, I _D = 16.7 A, R _G = 25 Ω (Note 3,4)	-	63	-	ns
t _r	Turn-On Rise Time		-	32	-	ns
t _{d(off)}	Turn-Off Delay Time		-	281	-	ns
t _f	Turn-Off Fall Time		-	20	-	ns
Q _{g(}	Total Gate Charge	V _{DS} = 520 V, I _D = 16.7 A, V _{GS} = 10 V (Note 3,4)	-	75	-	nC
Q _{gs}	Gate-Source Charge		-	14	-	nC
Q _{gd}	Gate-Drain Charge		-	22	-	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	32	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	96	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 16.7 A	-	-	1.3	V
trr	Reverse Recovery Time	V _R = 400 V, I _F = 16.7 A di _F /dt = 100 A/μs	-	445	-	ns
Qrr	Reverse Recovery Charge		-	7.7	-	μC

Notes :

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $I_{AS}=3.4\text{ A}$ $V_{DD}=100\text{ V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$
3. Pulse Test : Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
4. Essentially Independent of Operating Temperature

Typical Characteristics

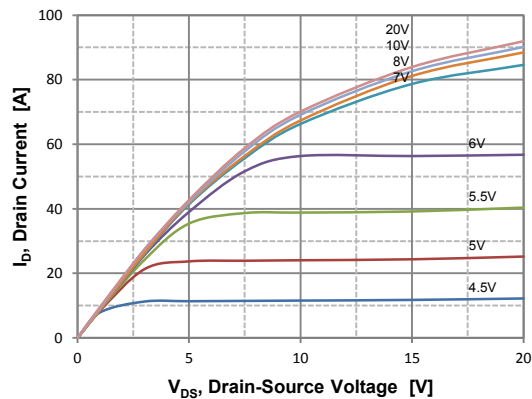


Figure 1. On Region Characteristics

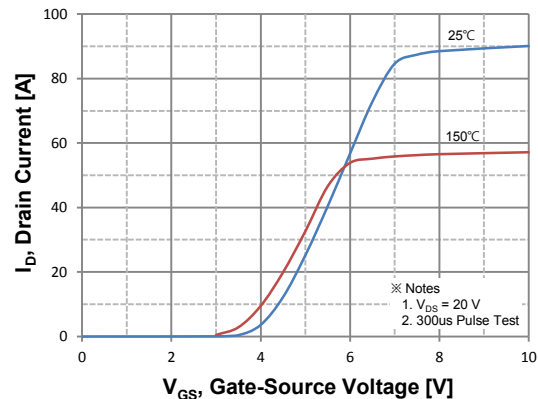


Figure 2. Transfer Characteristics

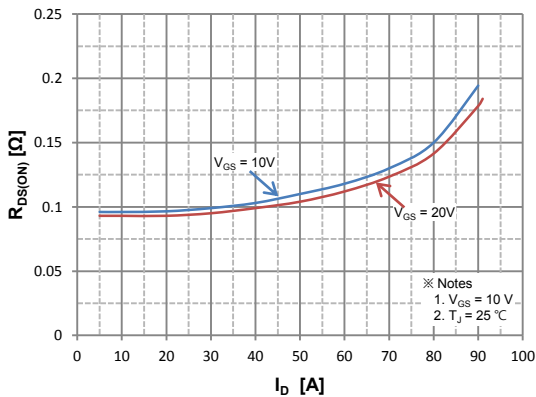


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

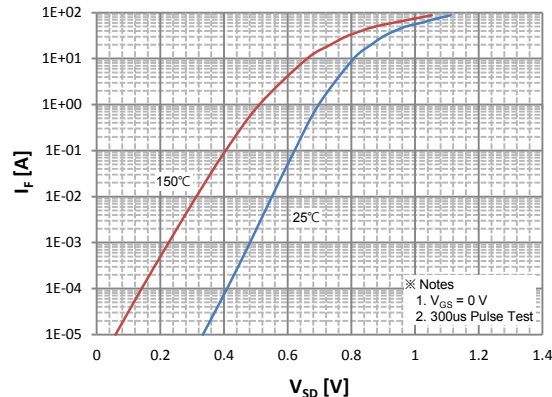


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

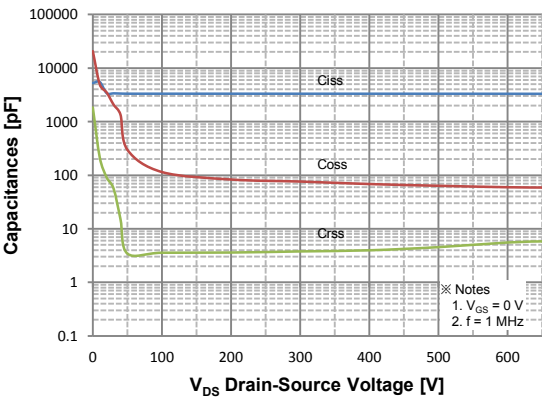


Figure 5. Capacitance Characteristics

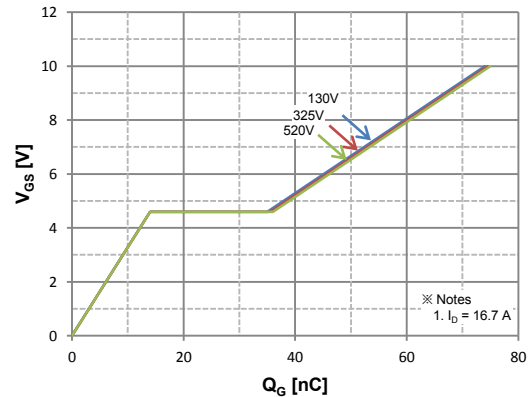


Figure 6. Gate Charge Characteristics

Typical Characteristics

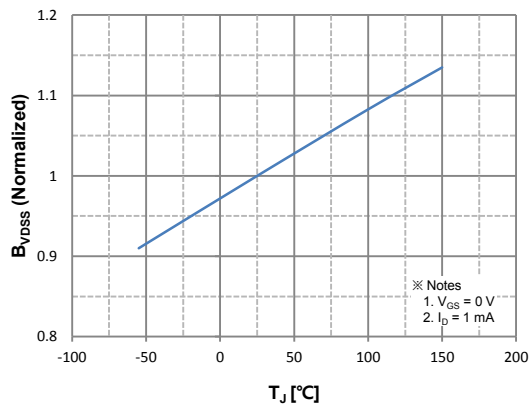


Figure 7. Breakdown Voltage Variation vs. Temperature

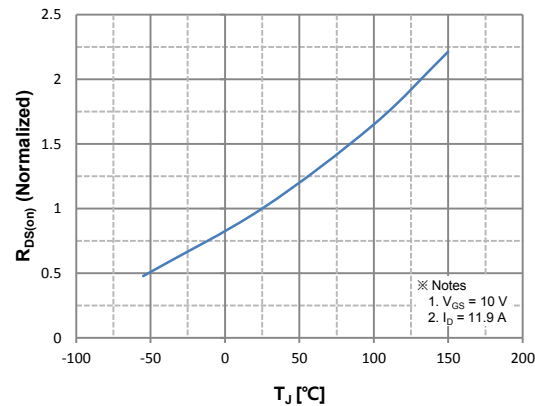


Figure 8. On-Resistance Variation vs. Temperature

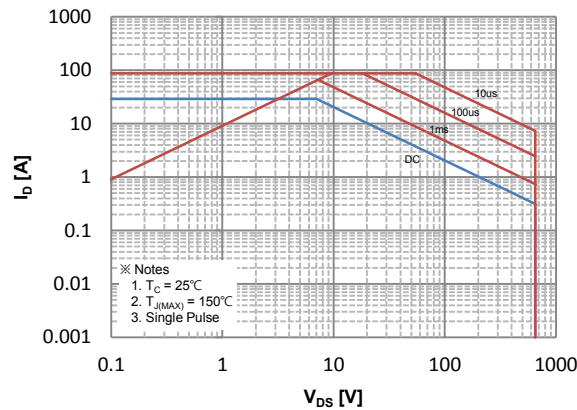


Figure 9. Maximum Safe Operating Area

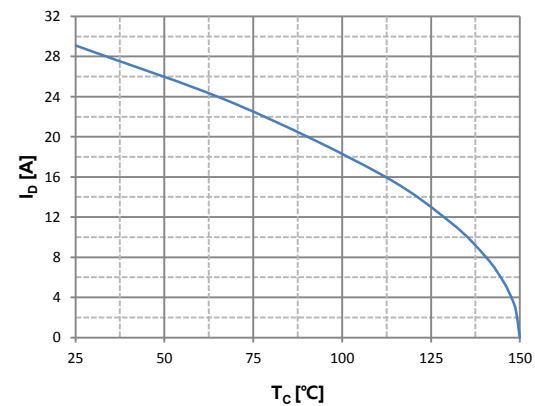


Figure 10. Maximum Drain Current vs. Case Temperature

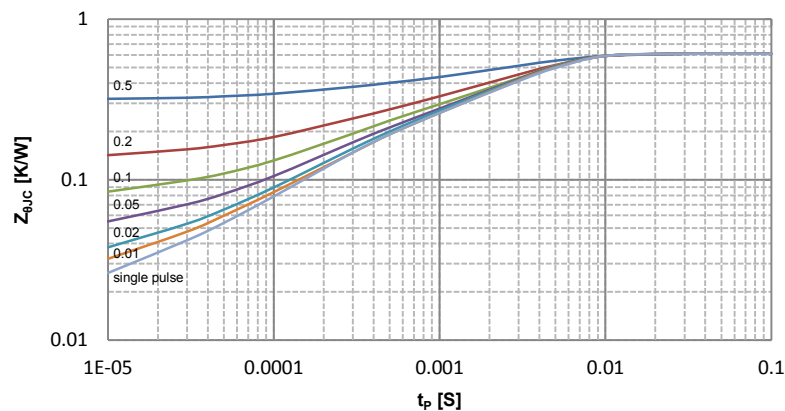


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

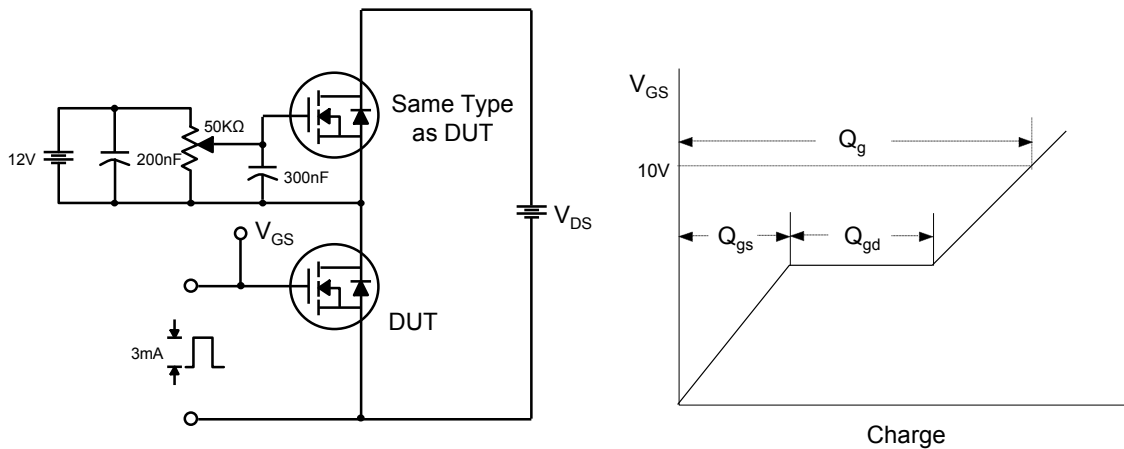


Fig 13. Resistive Switching Test Circuit & Waveforms

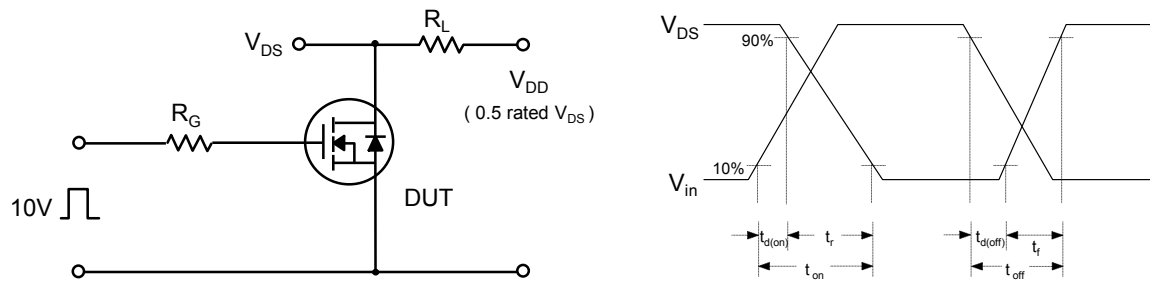


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

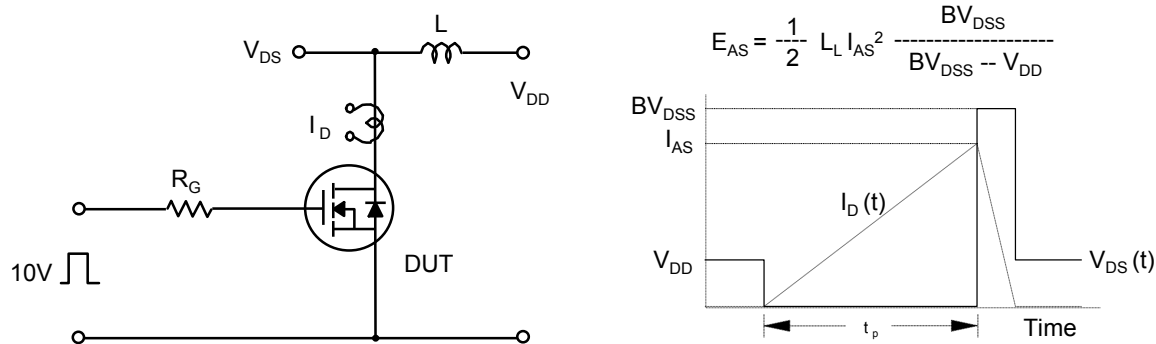
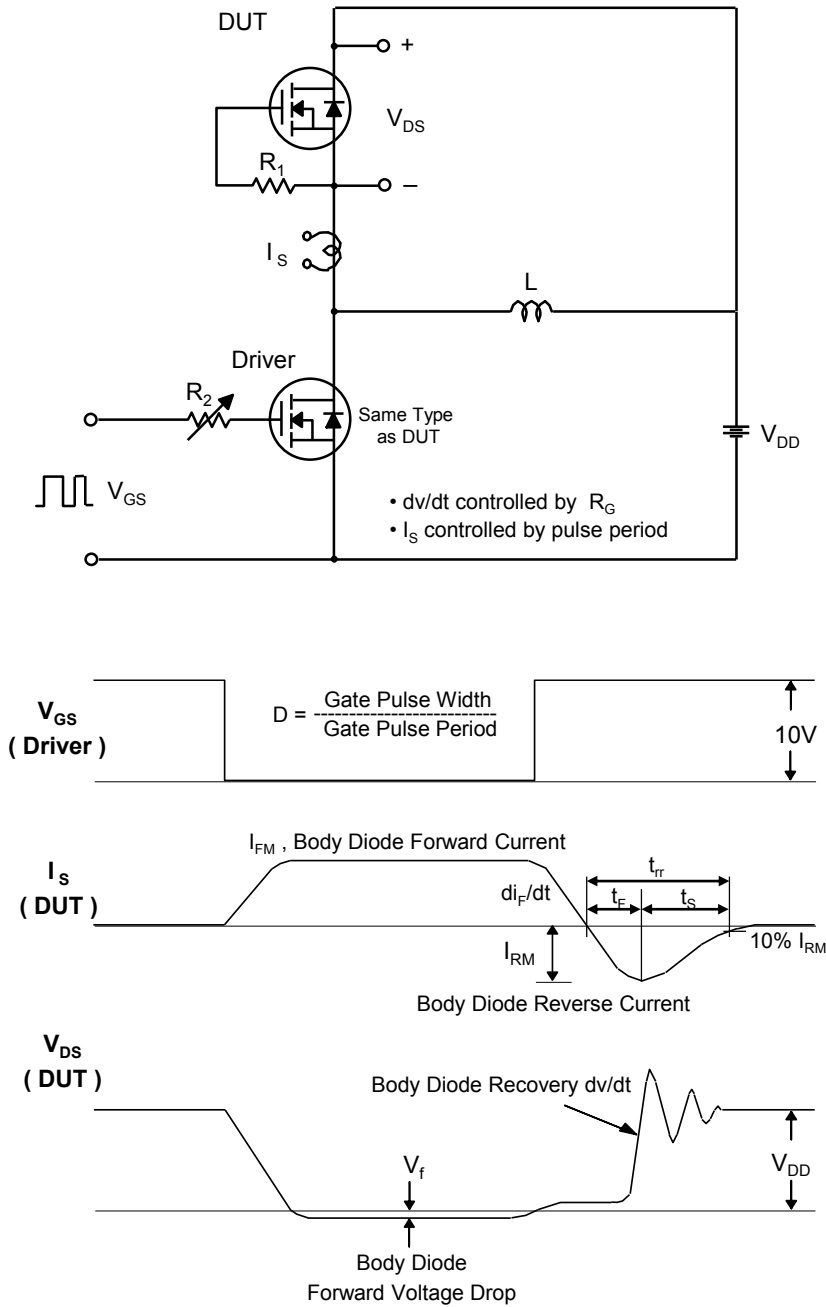
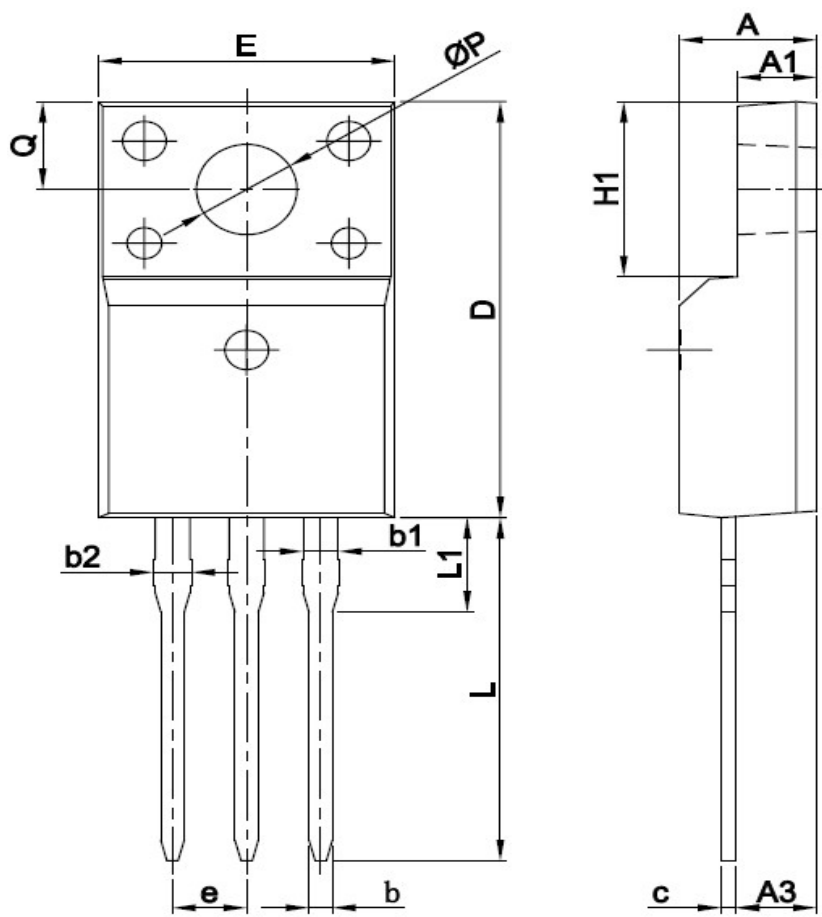


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Outline: TO-220F



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.30	4.90	0.169	0.193
A1	2.34	2.87	0.092	0.113
A3	2.20	2.96	0.087	0.117
b	0.60	0.90	0.024	0.035
b1	0.95	1.45	0.037	0.057
b2	1.15	1.55	0.045	0.061
c	0.40	0.70	0.016	0.028
D	15.50	16.17	0.610	0.637
e	2.54 BSC		0.100 BSC	
E	9.70	10.66	0.382	0.420
H1	6.70 REF		0.264 REF	
L	12.46	13.75	0.491	0.541
L1	2.80	3.80	0.110	0.150
Q	3.05	3.55	0.120	0.140
P	2.98	3.38	0.117	0.133